Atomic Structure Determination of Ba₄Ti₅O₁₀ and Ba₄Ti₄O₁₁ in Epitaxial Barium Titanate Nanodomains Using HRTEM and Electron Diffraction

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Perovskite BaTiO₃ thin films have a wide range of applications for advanced devices. Especially, epitaxial BaTiO₃ thin films are highly desirable for these advanced applications. So far, such epitaxial BaTiO₃ films have been successfully fabricated on different single-crystal substrates using various deposition techniques including RF magnetron sputtering, molecular beam epitaxy, metallorganic chemical vapor deposition and pulsed laser deposition. Among the deposition techniques, RF magnetron sputtering is becoming a very important deposition method due to its capability of depositing thin films over a large substrate area. The microstructure and physical properties of these films are strongly affected by the deposition conditions, such as chemical doping, deposition temperature, oxygen partial pressure, vacuum level, electric and mechanical stress fields and strain arising from the lattice and/or thermal expansion mismatch between the film and substrate.

Recently, we have fabricated barium titanate (BTO) thin films on MgO substrates using a home-made plasma assisted by RF magnetron sputtering system. A $BaTiO_3$ target of 99.999% purity was used for deposition. The MgO substrate surface was first cleaned using Ar plasma at room temperature for 10 minutes. The deposition temperature is 800 °C. A pressure of 1.333 Pa, an Ar gas flow rate of 10 cm³/min and a RF power of 50 W were used for film deposition. The as-deposited films exhibit interesting ferroelectric properties entirely different from those of perovskite $BaTiO_3$ resulting from the presence of the two new superstructures formed during deposition. In this work, we report on the atomic structure determination of the two new structures using electron diffraction and HRTEM.

Systematic studies using X-ray photoelectron spectroscopy, X-ray diffraction and cross-section and plan-view TEM demonstrated that the BTO thin films consist of epitaxial nanodomains structures of two new superstructures Γ_{γ} and H_{β} (Figure 1). Due to the nanometer scale size of the domains and the complexity of the structure in the film, the single crystal x-ray diffraction technique was inadequate to conduct the crystallographic structure determination of the two new superstructures. We used nanobeam electron diffraction to reconstruct the three-dimensional diffraction space and hence the symmetry of the new superstructures. Both Γ_{γ} and H_{β} were found to be monoclinic structures with a space group of *Cm* (*b*-unique axis). The Γ_{γ} phase was identified as a monoclinic Ba₄Ti₅O₁₀ structure with a space group of *Cm* (No. 8, è-unique axis) and lattice parameters of a = 16.49 Å, b = 3.94 Å, c = 8.94 Å and β = 103°(Fig. 2(a)), while the H_{β} phase was identified as a monoclinic Ba₄Ti₄O₁₁ with a = 17.88 Å, b = 3.94 Å, c = 7.21 Å and β = 98° (Fig. 2(b)). Atomic structural models for the two new superstructures were established by reconstructing the HRTEM images taken from the three major axes and refined by matching the simulated HRTEM images and calculated electron diffraction patterns with the experimental results. The two superstructures are epitaxially grown on MgO with their *b*-axis parallel to the growth direction followed by a primary orientation relationship:

- $[1] (010)_{I\gamma} // (001)_{MgO}, [20\overline{1}]_{I\gamma} // [100]_{MgO} \text{ and } [104]_{I\gamma} // [010]_{MgO}, \text{ for } \boldsymbol{\Gamma}_{\boldsymbol{\mathcal{Y}}}$

References:

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Figure 1. (a) Plan-view TEM image and (b) SAED pattern of the BTO thin films deposited using RFmagnetron sputtering showing the presence of multi-oriented nano-domain structures of two new superstructures (Γ and H).



Figure 2. Illustration of the atomic structural model of (a) Γ_{2} (Ba₄Ti₅O₁₀) and H_{β} (Ba₄Ti₄O₁₀).